

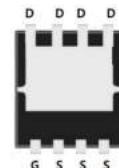


Features

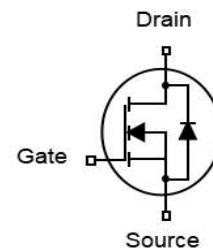
- N-Channel
- Excellent Gate Charge × $R_{DS(on)}$ (FOM)
- Ultra-low on-resistance
- RoHS compliant (Note 1)
- Halogen-free (Note 1)
- 100% EAS Tested

V_{DS}	40	V
$R_{DS(on),TYP}$ @ $V_{GS}=10$ V	2.9	$m\Omega$
$R_{DS(on),TYP}$ @ $V_{GS}=4.5$ V	3.5	$m\Omega$
I_D	100	A

DFN5x6



Part ID	Package Type	Marking	Packing
ZTG022N04G	DFN5x6	ZTG022N04G	5000pcs/Reel



Absolute Maximum Ratings $T_A = 25^\circ C$, unless otherwise specified

Symbol	Parameter	Rating	Unit
Common Ratings ($T_c=25^\circ C$ Unless Otherwise Noted)			
V_{GS}	Gate-Source Voltage	± 20	V
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	40	V
T_J	Maximum Junction Temperature	150	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
I_{DM}	Drain Current-Continuous@ Current-Pulsed (Note 2)	$T_c = 25^\circ C$	A
Mounted on Large Heat Sink			
I_D	Drain Current-Continuous (Note 1)	$T_c = 25^\circ C$	100
		$T_c = 100^\circ C$	68
P_D	Maximum Power Dissipation	67	W
$R_{\theta JC}$	Thermal Resistance-Junction to Case	1.85	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance Junction-Ambient (Note 4)	52	$^\circ C/W$
Drain-Source Avalanche Ratings			
EAS	Avalanche Energy, Single Pulsed (Note 3)	110	mJ



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Electrical Characteristics @ T_j=25°C (unless otherwise stated)						
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	40	--	--	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} =0V	--	--	1	μA
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.2	1.7	2.2	V
R _{D(on)}	Drain-Source On-State Resistance	V _{GS} =10V, I _D =30A	--	2.9	3.5	mΩ
R _{D(on)}	Drain-Source On-State Resistance	V _{GS} =4.5V, I _D =30A	--	3.5	5.0	mΩ
Dynamic Electrical Characteristics @ T_j = 25°C (unless otherwise stated) (Note 5)						
C _{iss}	Input Capacitance	V _{DS} =20V, V _{GS} =0V, f=1MHz	--	1846	--	pF
C _{oss}	Output Capacitance		--	606	--	pF
C _{rss}	Reverse Transfer Capacitance		--	28	--	pF
R _g	Gate Resistance	f=1MHz	--	7.2	--	Ω
Q _g	Total Gate Charge	V _{DD} =20V, I _D =20A, V _{GS} =10V	--	28	--	nC
Q _{gs}	Gate-Source Charge		--	4.5	--	nC
Q _{gd}	Gate-Drain Charge		--	5.6	--	nC
Switching Characteristics (Note 5)						
T _{d(on)}	Turn-on Delay Time	V _{DD} =20V, R _L =1.0Ω, R _G =6.0Ω, V _{GS} =10V	--	9	--	ns
T _r	Turn-on Rise Time		--	50	--	ns
T _{d(off)}	Turn-Off Delay Time		--	44.9	--	ns
T _f	Turn-Off Fall Time		--	76	--	ns
Source- Drain Diode Characteristics@ T_j = 25°C (unless otherwise stated)						
I _S	Diode Forward Current (Note 3)		--	--	100	A
V _{SD}	Forward on voltage (Note 6)	I _S =1A, V _{GS} =0V	--	--	1.0	V
T _{rr}	Reverse Recovery Time (Note 4)	T _j =25°C, I _D =15A di/dt=100A/μs	--	40	--	ns
Q _{rr}	Reverse Recovery Charge		--	27	--	nC

Notes:

- The max drain current rating is limited by T_{JMAX}
- Repetitive Rating: Pulse width limited by maximum junction temperature
- L = 0.5 mH, V_{DD} = 50V, I_{AS} = 21A, R_G = 25 Ω, Starting T_J = 25 °C
- Mount on minimum PCB layout

Electrical Characteristics Diagrams

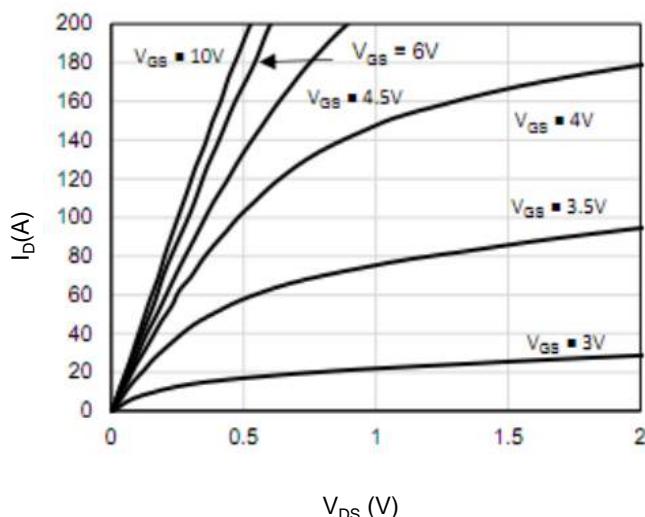


Figure 1: On-Region Characteristics

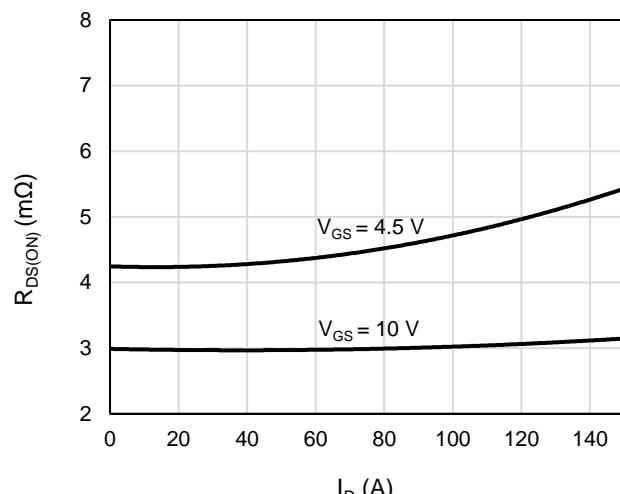


Figure 4: On-Resistance vs. Drain Current and Gate Voltage

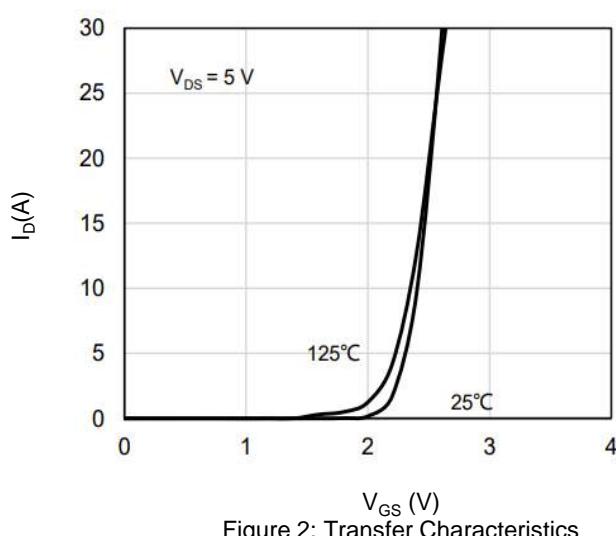


Figure 2: Transfer Characteristics

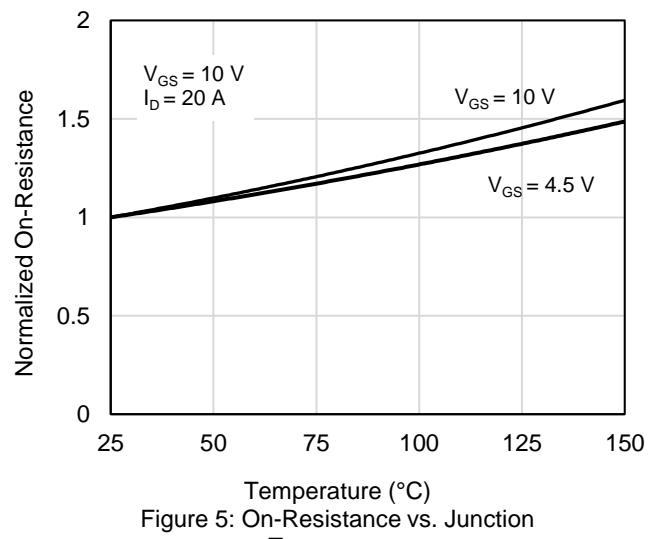


Figure 5: On-Resistance vs. Junction Temperature

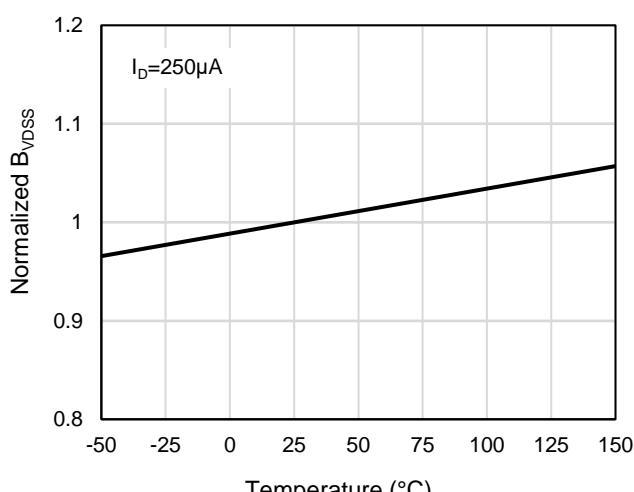


Figure 3: Breakdown Voltage vs. Junction Temperature

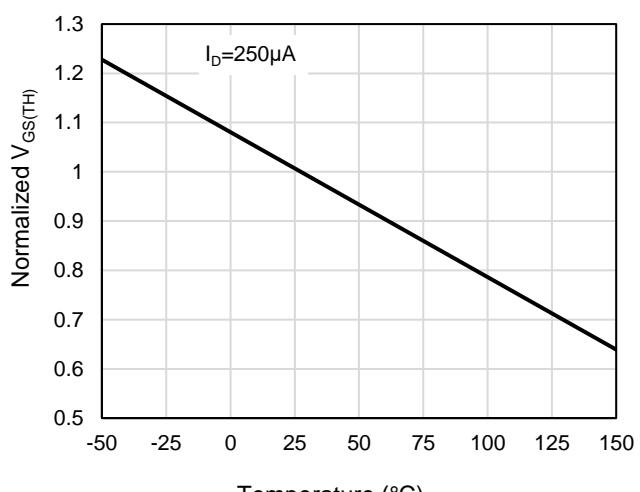


Figure 6: Threshold Voltage vs. Junction Temperature

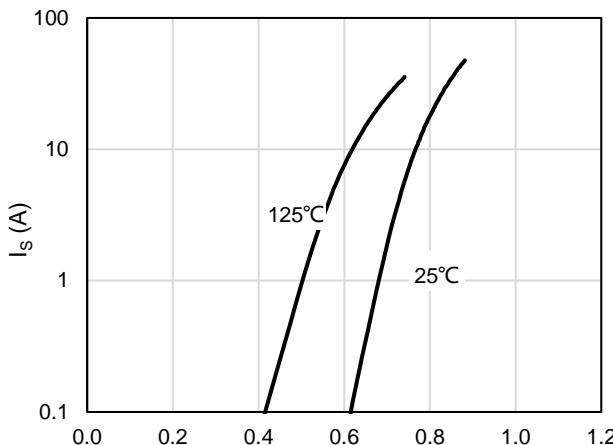


Figure 7: Body-Diode Characteristics

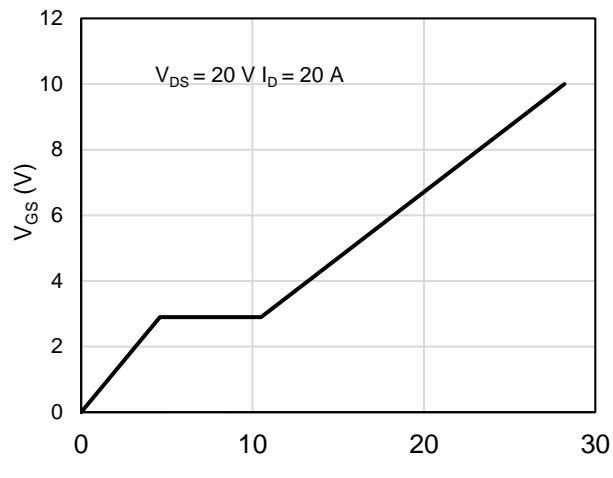


Figure 10: Gate-Charge Characteristics

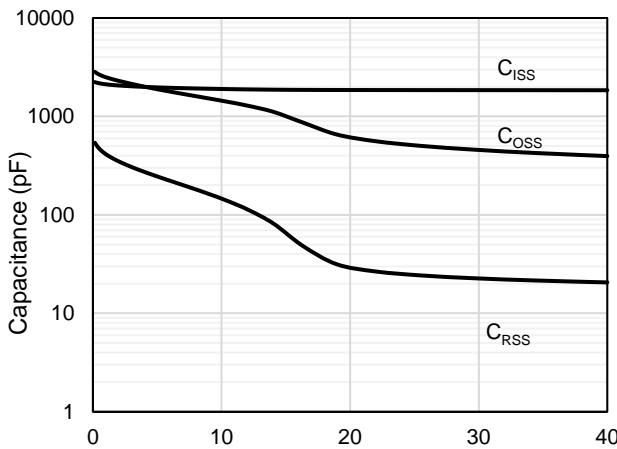


Figure 8: Capacitance Characteristics

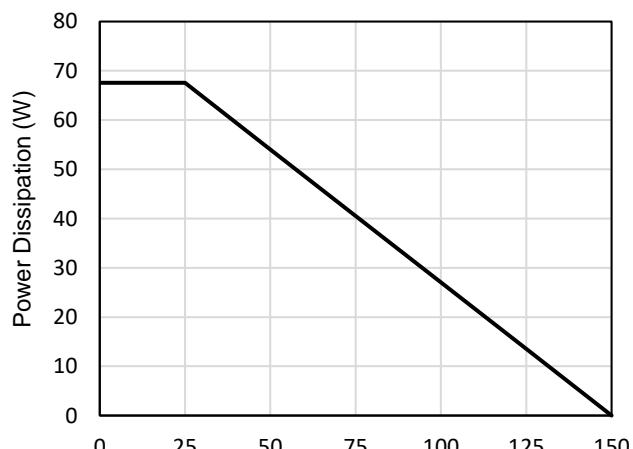


Figure 11: Power De-rating

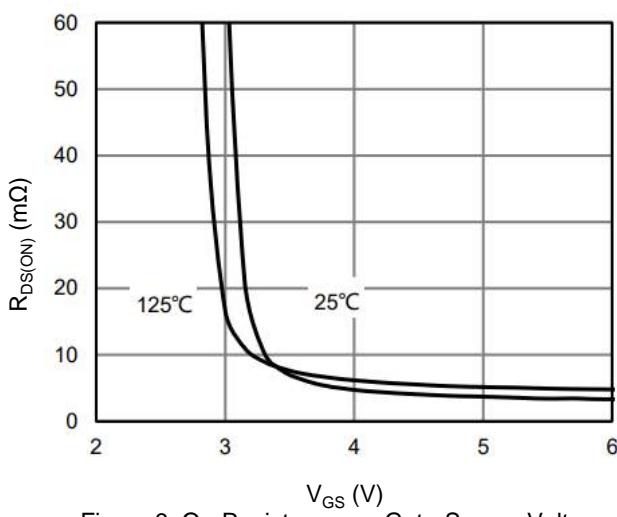


Figure 9: On-Resistance vs. Gate-Source Voltage

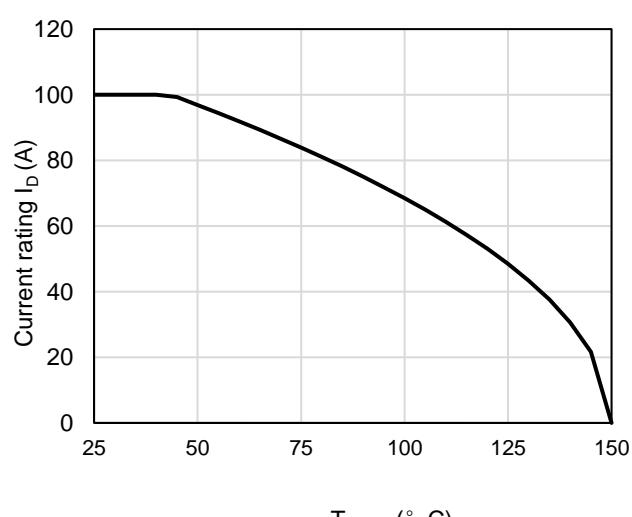


Figure 12: Current De-rating

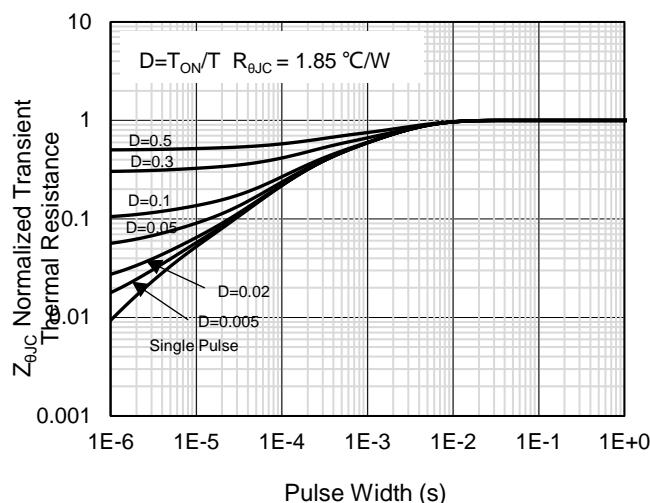


Figure 13: Normalized Maximum Transient Thermal Impedance

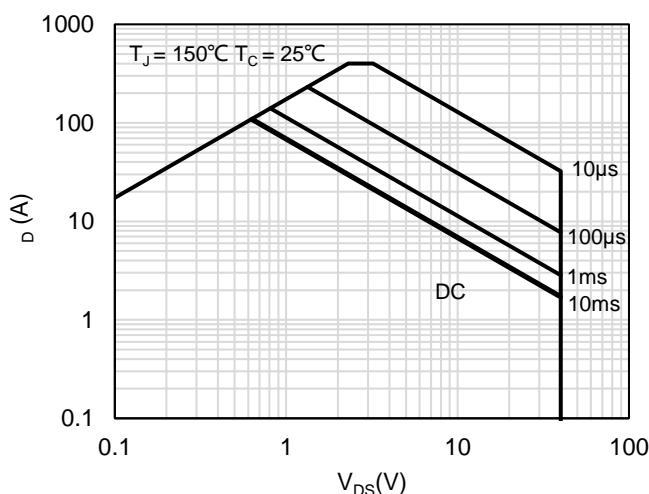
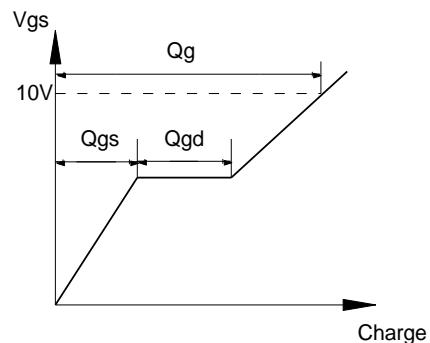
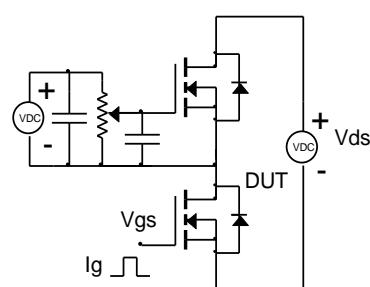


Figure 14: Maximum Forward Biased Safe Operating Area

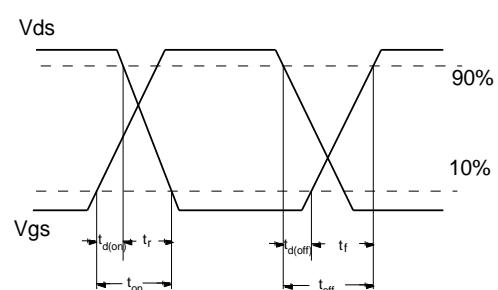
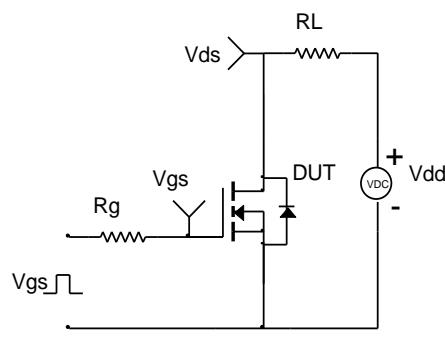


Test Circuit and Waveform

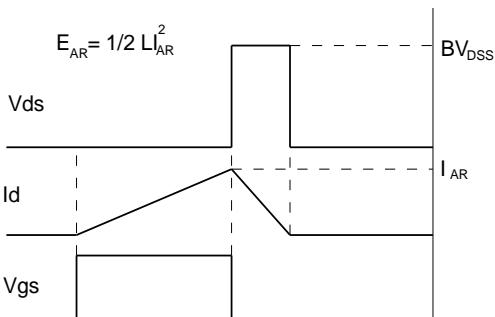
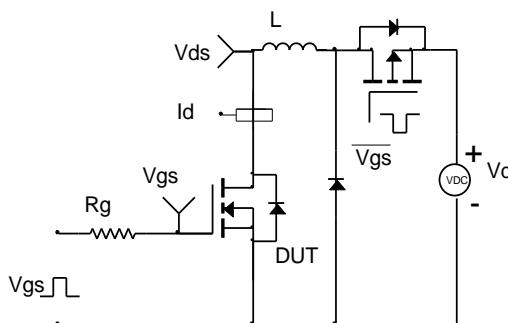
Gate Charge Test Circuit & Waveform



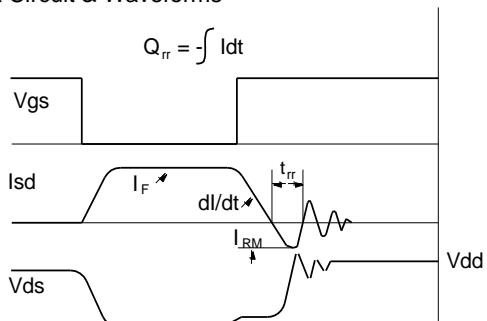
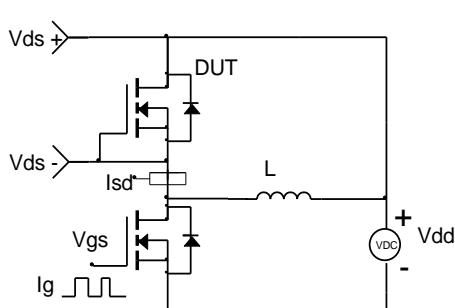
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

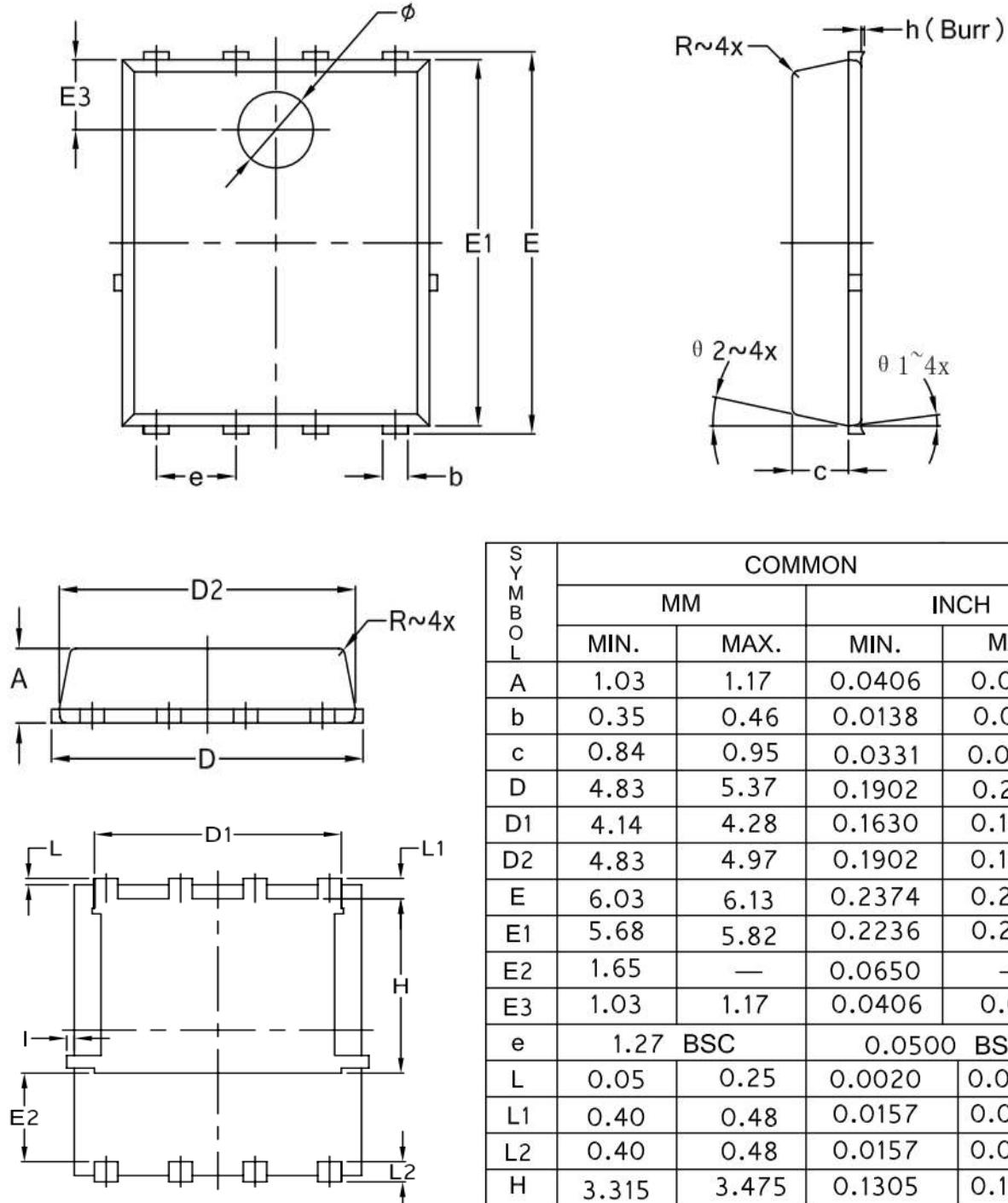


Diode Recovery Test Circuit & Waveforms





DFN5x6-8L Package Information



SYMBOL	COMMON			
	MM		INCH	
	MIN.	MAX.	MIN.	MAX.
A	1.03	1.17	0.0406	0.0461
b	0.35	0.46	0.0138	0.0181
c	0.84	0.95	0.0331	0.0374
D	4.83	5.37	0.1902	0.2114
D1	4.14	4.28	0.1630	0.1685
D2	4.83	4.97	0.1902	0.1957
E	6.03	6.13	0.2374	0.2413
E1	5.68	5.82	0.2236	0.2291
E2	1.65	—	0.0650	—
E3	1.03	1.17	0.0406	0.0461
e	1.27	BSC	0.0500	BSC
L	0.05	0.25	0.0020	0.0098
L1	0.40	0.48	0.0157	0.0189
L2	0.40	0.48	0.0157	0.0189
H	3.315	3.475	0.1305	0.1368
I	—	0.16	—	0.0063
ϕ	1.13	1.27	0.0445	0.0500
R	0.10		0.0039	
θ1	7° REF		7° REF	
θ2	12° REF		12° REF	
h	0.08 MAX		0.0031	

Customer Service

Sales and Service:

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